

March 1988 Revised August 1999

74F841 10-Bit Transparent Latch

General Description

The 74F841 bus interface latch is designed to eliminate the extra packages required to buffer existing latches and provide extra data width for wider address/data paths or buses carrying parity. The 74F841 is a 10-bit transparent latch, a 10-bit version of the 74F373.

Features

■ 3-STATE output

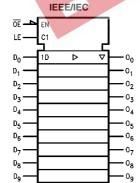
Ordering Code:

Order Number	Package Number	Package Description
74F841SC	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74F841SPC	N24C	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-100, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols





Connection Diagram



Unit Loading/Fan Out

Pin Names	Description	U.L. HIGH/LOW	Input I _{IH} /I _{IL} Output I _{OH} /I _{OL}		
D ₀ –D ₉	Data Inputs	1.0/1.0	20 μA/–0.6 mA		
O ₀ -O ₉	3-STATE Outputs	150/40	−3 mA/24 mA		
ŌĒ	Output Enable Input	1.0/1.0	20 μA/-0.6 mA		
LE	Latch Enable	1.0/1.0	20 μA/-0.6 mA		

Functional Description

The 74F841 device consists of ten D-type latches with 3-STATE outputs. The flip-flops appear transparent to the data when Latch Enable (LE) is HIGH. This allows asynchronous operation, as the output transition follows the data in transition.

On the LE HIGH-to-LOW transition, the data that meets the setup and hold time is latched. Data appears $\underline{\mbox{ on }}$ the bus when the Output Enable ($\overline{\text{OE}}$) is LOW. When $\overline{\text{OE}}$ is HIGH the bus output is in the high impedance state.

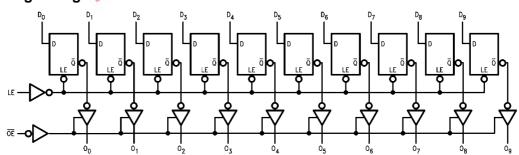
Function Table

	Inputs		Internal Output		Function		
	OE	LE	D	Q	0	runction	
	Χ	Χ	Χ	Х	Z	High Z	
	Н	Н	L	L	Z	High Z	
	Н	Н	Н	H.S	Z	High Z	
	Н	L	X	NC	Z	Latched	
	L	He	L	L	L	Transparent	
	L/S	, НЭ	H	H	Н	Transparent	
g,		Ľ	X	NC	NC	Latched	
	₽L.	X	Χ	Н	Н	Preset	
	L c	Χ	Χ	L	L	Clear	
	1	X	Χ	Н	Н	Preset	
	Н	L	Χ	L	Z	Latched	
	Н	L	Χ	Н	Z	Latched	

- H = HIGH Voltage Level
 L = LOW Voltage Level
 X = Immaterial
 Z = HIGH Impedance

- NC = No Change

Logic Diagram



Absolute Maximum Ratings(Note 1)

Storage Temperature -65°C to $+150^{\circ}\text{C}$ Ambient Temperature under Bias -55°C to $+125^{\circ}\text{C}$ Junction Temperature under Bias -55°C to $+150^{\circ}\text{C}$

 $\begin{array}{lll} \text{V}_{\text{CC}} \text{ Pin Potential to Ground Pin} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Voltage (Note 2)} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Current (Note 2)} & -30 \text{ mA to } +5.0 \text{ mA} \\ \end{array}$

Voltage Applied to Output

in HIGH State (with $V_{CC} = 0V$)

 $\begin{array}{ccc} \text{Standard Output} & & -0.5 \text{V to V}_{\text{CC}} \\ \text{3-STATE Output} & & -0.5 \text{V to +5.5V} \end{array}$

Current Applied to Output

in LOW State (Max) $\qquad \qquad \text{twice the rated I}_{\text{OL}} \, (\text{mA})$

Recommended Operating Conditions

Free Air Ambient Temperature $0^{\circ}\text{C to } +70^{\circ}\text{C}$ Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

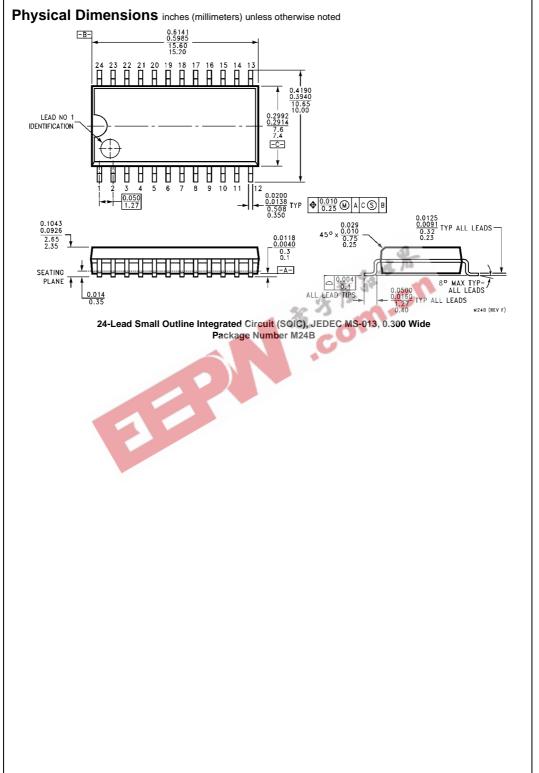
Symbol	Parameter	Min	Тур	Max	Units	V _{CC}	Conditions	
V _{IH}	Input HIGH Voltage	2.0			V	18. M	Recognized as a HIGH Signal	
V _{IL}	Input LOW Voltage			8.0	V	•	Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltage			-1.2	V	Min	I _{IN} = −18 mA	
V _{OH}	Output HIGH Voltage 10% V _{CC}	2.5		20 1	1 1	19	l _{OH} = −1 mA	
	10% V _{CC}	2.4		32		Min	$I_{OH} = -3 \text{ mA}$	
	5% V _{CC}	2.7		40	O.	IVIIII	$I_{OH} = -1 \text{ mA}$	
	5% V _{CC}	2.7					$I_{OH} = -3 \text{ mA}$	
V _{OL}	Output LOW			0.5	V	Min	1 24 m A	
	Voltage			0.5	v	IVIII	$I_{OL} = 24 \text{ mA}$	
I _{IH}	Input HIGH			5.0		Max	V _{IN} = 2.7V	
	Current			5.0	μА	IVIAX	$V_{IN} = 2.7 V$	
I _{BVI}	Input HIGH Current		-	7.0		Max	V _{IN} = 7.0V	
	Breakdown Test			7.0	μΑ	IVIAX	V _{IN} = 7.0 V	
I _{CEX}	Output HIGH			50	μА	Max	V _{OUT} = V _{CC}	
	Leakage Current			00	μιτ	IVIAX	▲O01 - ▲CC	
V _{ID}	Input Leakage	4.75			V	0.0	$I_{ID} = 1.9 \mu\text{A}$	
	Test	4.73			v	0.0	All Other Pins Grounded	
I _{OD}	Output Leakage			3.75	μА	0.0	V _{IOD} = 150 mV	
	Circuit Current			3.73			All Other Pins Grounded	
I _{IL}	Input LOW Current			-0.6	mA	Max	$V_{IN} = 0.5V$	
I _{OZH}	Output Leakage Current			50	μΑ	Max	V _{OUT} = 2.7V	
I _{OZL}	Output Leakage Current			-50	μΑ	Max	V _{OUT} = 0.5V	
Ios	Output Short-Circuit Current	-60		-150	mA	Max	$V_{OUT} = 0V$	
I _{ZZ}	Bus Drainage Test			500	μА	0.0V	V _{OUT} = 5.25V	
I _{CCZ}	Power Supply Current		69	92	mA	Max	$V_0 = HIGH Z$	

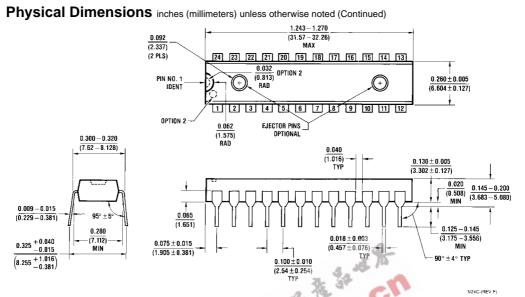
AC Electrical Characteristics

Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_{A} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		Units
		Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	2.5		8.0	2.0	9.0	ns
t _{PHL}	D _n to O _n	1.5		6.5	1.5	7.0	115
t _{PLH}	Propagation Delay	5.0		12.0	4.5	13.5	
t _{PHL}	LE to O _n	2.0		7.5	2.0	8.0	ns
t _{PZH}	Output Enable Time	2.5		8.5	2.0	9.5	
t_{PZL}	OE to O _n	2.5		9.0	2.0	10.0	
t _{PHZ}	Output Disable Time	1.0		6.5	1.0	7.5	ns
t _{PLZ}	OE to On	1.0		6.5	1.0	7.5	

AC Operating Requirements

		T _A = +25°C	T _A = 0°C to +70°C	
Symbol	Parameter	V _{CC} = +5.0V	V _{CC} = +5.0V	Units
		Min Max	Min Max	
t _S (H)	Setup Time, HIGH or LOW	2.0	2.5	
t _S (L)	D _n to LE	2.0	2.5	ns
t _H (H)	Hold Time, HIGH or LOW	2.5	3.0	115
t _H (L)	D _n to LE	3.0	3.5	
t _W (H)	LE Pulse Width, HIGH	4.0	4.0	ns





24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-100, 0.300 Wide Package Number N24C

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